

Notice of References Cited	Application/Control No. 10/046,240	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner David A. Rogers	Art Unit 2856	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,731,530	05-1973	Tanguy et al.	73/152.42
	B	US-3,939,693	02-1976	Dumont, Philippe A.	73/19.05
	C	US-4,056,002	11-1977	Arieh et al.	73/861.04
	D	US-4,168,624	09-1979	Pichon, Denis	73/195
	E	US-4,516,580	05-1985	Polanyi, Michael L.	600/364
	F	US-4,584,866	04-1986	Janssen, Wladmir	73/19.1
	G	US-4,862,729	09-1989	Toda et al.	73/19.05
	H	US-4,924,695	05-1990	Kolpak, Miroslav M.	73/19.01
	I	US-5,041,990	08-1991	Yabumoto et al.	702/24
	J	US-5,635,631	06-1997	Yesudas et al.	73/61.46
	K	US-5,846,831	12-1998	Silvis, William M.	436/55
	L	US-6,393,893	05-2002	Fetz et al.	73/19.01
	M	US-2003/0051531	03-2003	Patashnick et al.	73/28.01

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.